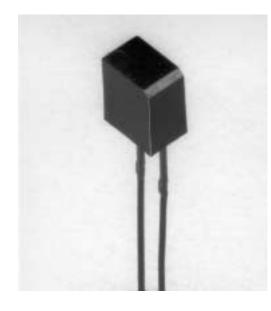
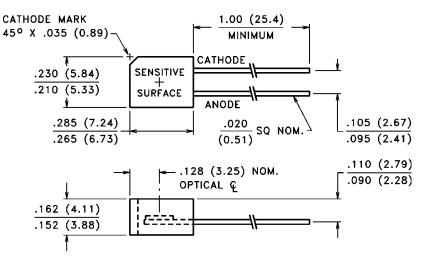
# **VTP Process Photodiodes**

# **VTP100H**



#### PACKAGE DIMENSIONS inch (mm)



CASE 52 FLAT SIDELOOKER CHIP ACTIVE AREA: .012 in<sup>2</sup> (7.45 mm<sup>2</sup>)

### **ABSOLUTE MAXIMUM RATINGS**

Storage Temperature:	-40°C to 100°C
Operating Temperature:	-40°C to 100°C

## **RoHS Compliant**



### ELECTRO-OPTICAL CHARACTERISTICS @ 25°C (See also VTP curves, pages 45-46)

SYMBOL	CHARACTERISTIC TEST CONDITIONS	VTP100H				
		TEST CONDITIONS	Min.	Тур.	Max.	UNITS
I <sub>SC</sub>	Short Circuit Current	H = 100 fc, 2850 K	35	55		μA
TC I <sub>SC</sub>	I <sub>SC</sub> Temperature Coefficient	2850 K		.24		%/°C
V <sub>OC</sub>	Open Circuit Voltage	H = 100 fc, 2850 K		300		mV
TC V <sub>OC</sub>	V <sub>OC</sub> Temperature Coefficient	2850 K		-2.0		mV/°C
۱ <sub>D</sub>	Dark Current	H = 0, VR = 10 V			30	nA
R <sub>SH</sub>	Shunt Resistance	H = 0, V = 10 mV		.25		GΩ
CJ	Junction Capacitance	H = 0, V = 3 V			50	pF
Re	Responsivity	940 nm	.036	.047		A/(W/cm <sup>2</sup> )
S <sub>R</sub>	Sensitivity	@ Peak		.50		A/W
$\lambda_{range}$	Spectral Application Range		725		1150	nm
λ <sub>p</sub>	Spectral Response - Peak			925		nm
V <sub>BR</sub>	Breakdown Voltage		30	140		V
θ <sub>1/2</sub>	Angular Resp 50% Resp. Pt.			±70		Degrees
NEP	Noise Equivalent Power		2.5 x 10 <sup>-14</sup> (Typ.)			W∕√Hz
D*	Specific Detectivity		1.1 x 10 <sup>13</sup> (Typ.)			cm√Hz∕W



nordics@amstechnologies.com azpect.amstechnologies.com

#### PRODUCT DESCRIPTION

Planar silicon photodiode in a molded plastic sidelooker package. The package material is infrared transmitting (blocking visible light). These diodes exhibit low dark current and fast speed of response.